



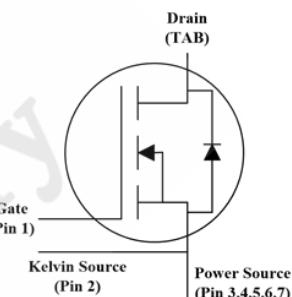
P3M12040G7 SiC MOS N-Channel Enhancement Mode

V_{RRM} = 1200 V
 I_D = 63 A
 I_D (100°C) = 44 A
 $R_{DS(on)}$ = 40 mΩ

SiC MOS P3M12040G7 N-Channel Enhancement Mode

Features

- Qualified to AEC-Q101
- High Blocking Voltage with Low On-Resistance
- High-Frequency Operation
- Ultra-Small Q_{gd}
- 100% UIS tested



Benefits

- Improve System Efficiency
- Increase Power Density
- Reduce Heat Sink Requirements
- Reduction of System Cost

TO-263-7

| Drain | TAB |
|---------------|-----|
| Gate | 1 |
| Kelvin Source | 2 |
| Power Source | 3~7 |

Applications

- Solar Inverters
- EV Battery Chargers
- High Voltage DC/DC Converters
- Switch Mode Power Supplies



Order Information

| Part Number | Package | Marking |
|-------------|----------|------------|
| P3M12040G7 | TO-263-7 | P3M12040G7 |



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P3M12040G7 SiC MOS

N-Channel Enhancement Mode

1. Maximum Ratings

At $T_J = 25^\circ\text{C}$, unless specified otherwise

| Parameter | Symbol | Value | Unit | Test Conditions |
|--|---|-----------------|------|--|
| Drain - Source Voltage | $V_{DS\max}$ | 1200 | V | $V_{GS} = 0\text{V}$ $I_D = 100\mu\text{A}$ |
| Gate - Source Voltage (dynamic) | $V_{GS\max}$ | -8 / +21 | V | AC ($f > 1\text{Hz}$) |
| Gate - Source Voltage(static) turn-on gate voltage turn-off gate voltage | $V_{GS,\text{on}}$ $V_{GS,\text{off}}$ | +15 / +18 -3 | V | Static |
| Continuous Drain Current | I_D | 63 | A | $V_{GS} = 15\text{V}$ $T_C = 25^\circ\text{C}$ |
| | | 44 | | $V_{GS} = 15\text{V}$ $T_C = 100^\circ\text{C}$ |
| Power Dissipation | P_D | 349 | W | |
| Operating Junction | T_J | -55 To +175 | °C | |
| Storage Temperature | T_{stg} | -55 To +175 | °C | |
| Solder Temperature | T_L | 260 | °C | |



2. Electrical Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

| Parameter | Symbol | Value | | | Unit | Test Conditions |
|----------------------------------|-----------------------------|-------|------|------|------------------|---|
| | | Min. | Typ. | Max. | | |
| Drain-Source Breakdown Voltage | $V_{(\text{BR})\text{DSS}}$ | 1200 | / | / | V | $V_{GS} = 0\text{V}$ $I_D = 100\mu\text{A}$ |
| Gate Threshold Voltage | $V_{GS(\text{th})}$ | 1.8 | 2.4 | / | V | (tested after 30ms pulse at $V_{GS} = 15\text{V}$) $V_{DS} = V_{GS}$ $I_D = 10\text{mA}$ $T_J = 25^\circ\text{C}$ |
| | | / | 1.6 | / | V | $V_{DS} = V_{GS}$ $I_D = 10\text{mA}$ $T_J = 175^\circ\text{C}$ |
| Reverse Bias Drain Current | I_{DSS} | / | 1 | 100 | μA | $V_{GS} = 0\text{V}$ $V_{DS} = 1200\text{V}$ |
| Gate-Source Leakage Current | I_{GSS} | / | 20 | 250 | nA | $V_{GS} = 15\text{V}$ $V_{DS} = 0\text{V}$ |
| Drain-Source On-State Resistance | $R_{DS(\text{on})}$ | / | 40 | 52 | $\text{m}\Omega$ | $V_{GS} = 15\text{V}$ $I_D = 40\text{A}$ $T_J = 25^\circ\text{C}$ |
| | | / | 59 | / | | $V_{GS} = 15\text{V}$ $I_D = 40\text{A}$ $T_J = 175^\circ\text{C}$ |
| | | / | 35 | / | | $V_{GS} = 18\text{V}$ $I_D = 40\text{A}$ $T_J = 25^\circ\text{C}$ |
| Transconductance | g_{fs} | / | 21 | / | S | $V_{DS} = 20\text{V}$ $I_{DS} = 40\text{A}$ $T_J = 25^\circ\text{C}$ |
| | | / | 20 | / | | $V_{DS} = 20\text{V}$ $I_{DS} = 40\text{A}$ $T_J = 175^\circ\text{C}$ |



P3M12040G7 SiC MOS
N-Channel Enhancement Mode

| Parameter | Symbol | Value | | | Unit | Test Conditions |
|------------------------------|--------------|-------|-------|------|----------|---|
| | | Min. | Typ. | Max. | | |
| Input Capacitance | C_{iss} | / | 3505 | / | pF | $V_{GS} = 0V$ $V_{DS} = 800V$ $f = 1MHz$ $V_{AC} = 25mV$ |
| Output Capacitance | C_{oss} | / | 125.6 | / | | |
| Reverse Transfer Capacitance | C_{rss} | / | 5.4 | / | | |
| Coss Stored Energy | E_{oss} | / | 91.1 | / | μJ | |
| Internal Gate Resistance | $R_{G(int)}$ | / | 1.3 | / | Ω | $f = 1MHz$ $V_{AC} = 25mV$ |
| Gate to Source Charge | Q_{gs} | / | 38 | / | nC | $V_{DS} = 800V$ $I_{DS} = 40A$ $V_{GS} = -3/15V$ $I_G = 5mA$ |
| Gate to Drain Charge | Q_{gd} | / | 19 | / | | |
| Total Gate Charge | Q_g | / | 98 | / | | |



3. Reverse Diode Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

| Parameter | Symbol | Value | | Unit | Test Conditions |
|----------------------------------|----------|-------|------|------|---|
| | | Typ. | Max. | | |
| Diode Forward Voltage | V_{SD} | 5.2 | / | V | $V_{GS} = -3\text{V}$ $I_{SD} = 20\text{A}$ $T_J = 25^\circ\text{C}$ |
| | | 4.9 | / | V | $V_{GS} = -3\text{V}$ $I_{SD} = 20\text{A}$ $T_J = 175^\circ\text{C}$ |
| Continuous Diode Forward Current | I_S | 51 | / | A | $V_{GS} = -3\text{V}$ |

4. Thermal Characteristics

| Parameter | Symbol | Value | Unit |
|--|-----------------|-------|---------------------------|
| Thermal Resistance from Junction to Case | $R_{\theta JC}$ | 0.43 | $^\circ\text{C}/\text{W}$ |



P3M12040G7 SiC MOS N-Channel Enhancement Mode

5. Typical Performance

At $T_J = 25^\circ\text{C}$, unless specified otherwise

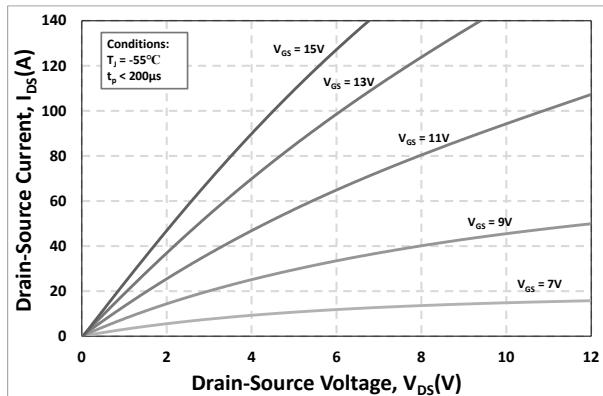


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

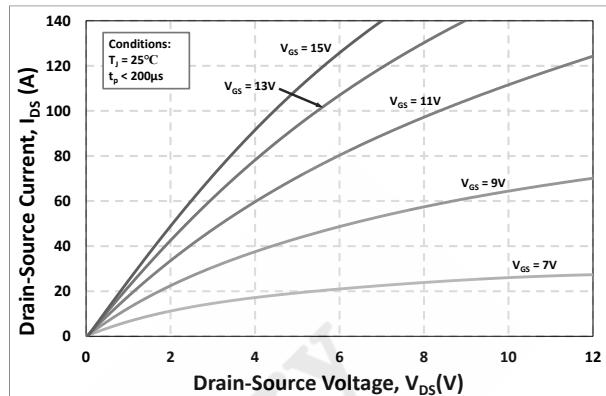


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

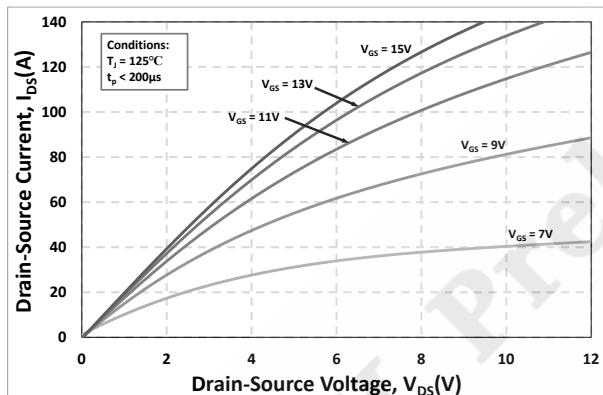


Figure 3. Output Characteristics $T_J = 125^\circ\text{C}$

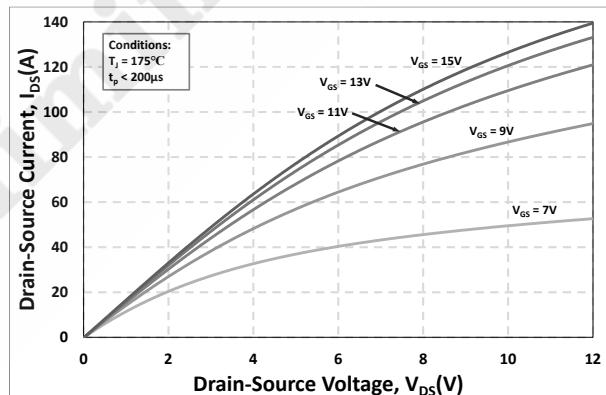


Figure 4. Output Characteristics $T_J = 175^\circ\text{C}$

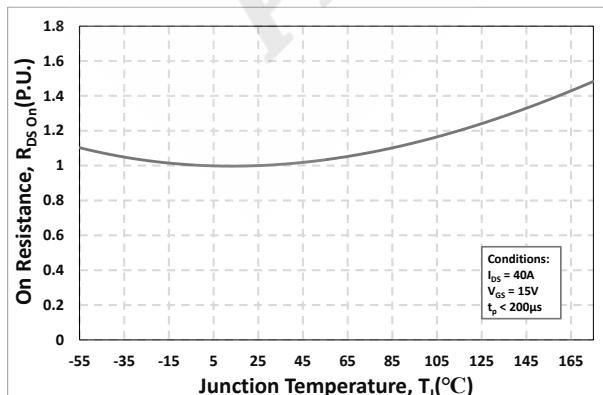


Figure 5. Normalized On-Resistance vs. Temperature

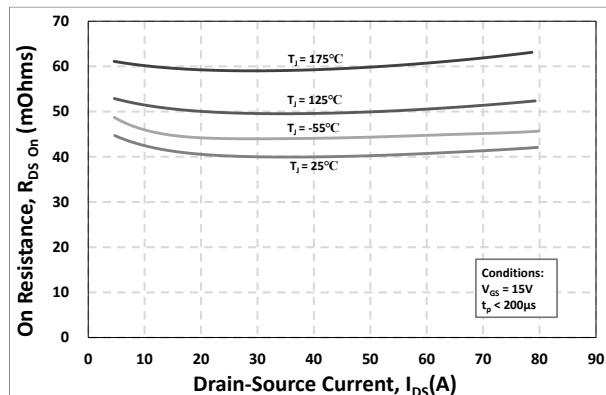


Figure 6. On-Resistance vs. Drain Current Various Temperatures



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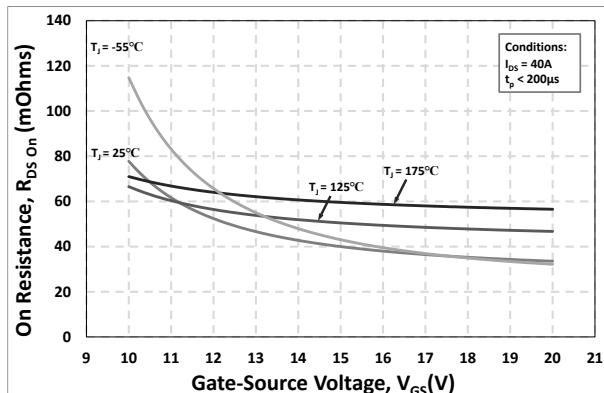


Figure 7. On-Resistance vs. Gate-Source Voltage

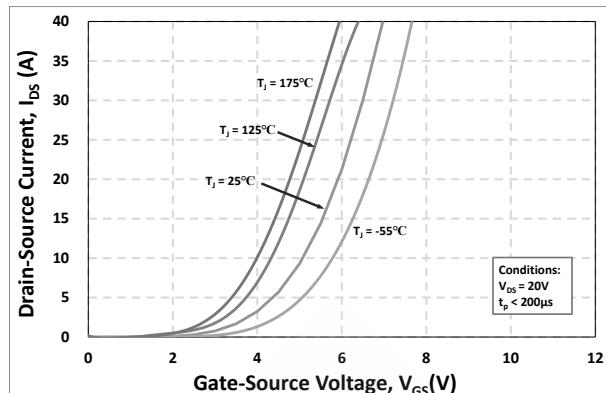


Figure 8. Transfer Characteristic for Various Junction Temperatures

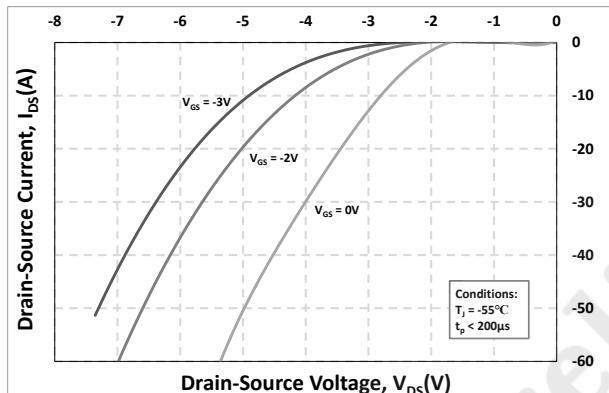


Figure 9. Body Diode Characteristic at -55°C

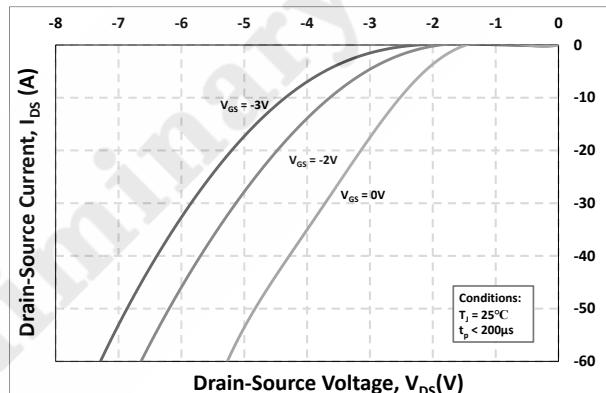


Figure 10. Body Diode Characteristic at 25°C

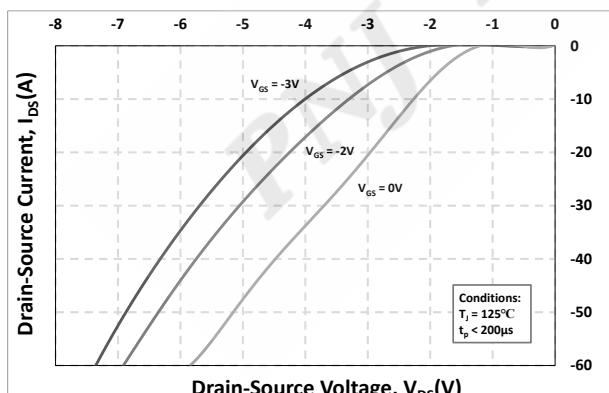


Figure 11. Body Diode Characteristic at 125°C

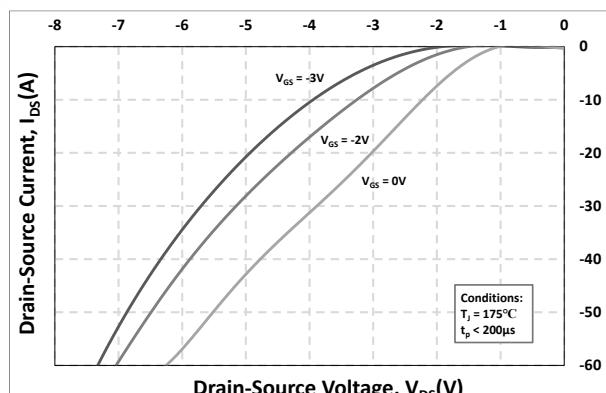


Figure 12. Body Diode Characteristic at 175°C



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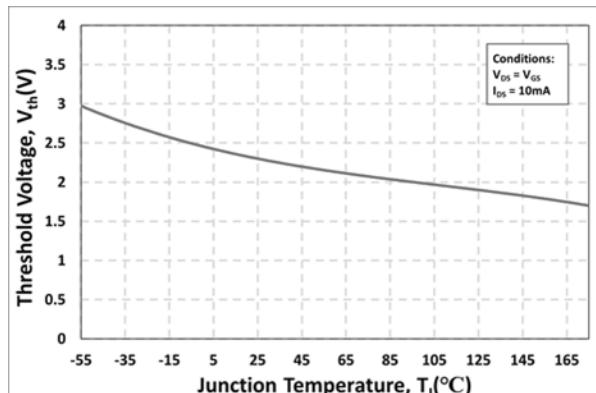


Figure 13. Threshold Voltage vs. Temperature

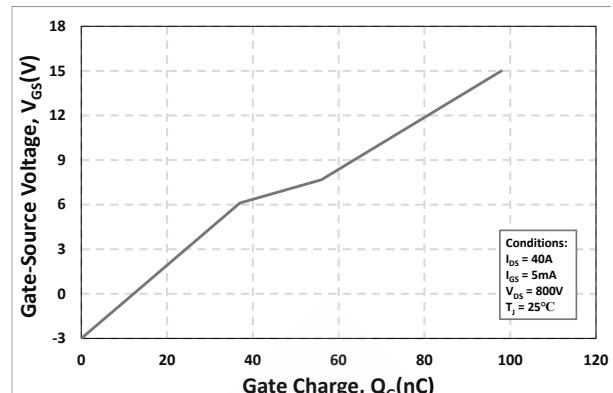


Figure 14. Gate Charge Characteristics

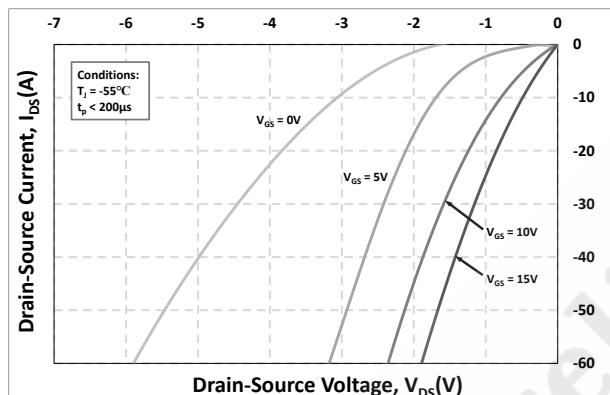


Figure 15. 3rd Quadrant Characteristic at -55°C

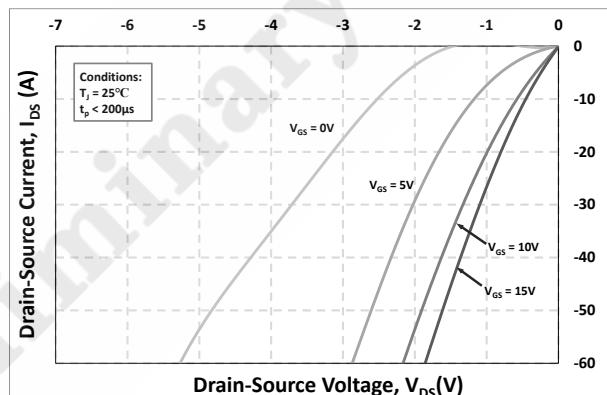


Figure 16. 3rd Quadrant Characteristic at 25°C

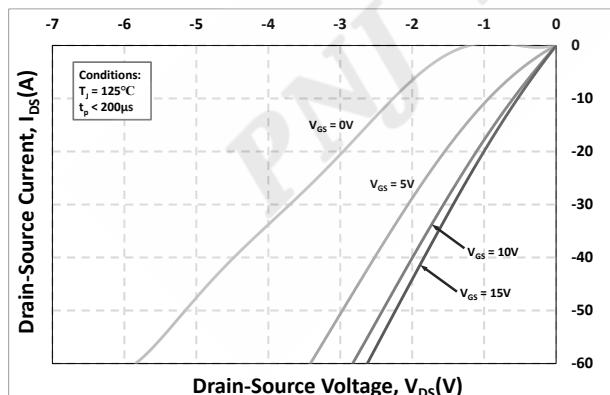


Figure 17. 3rd Quadrant Characteristic at 125°C

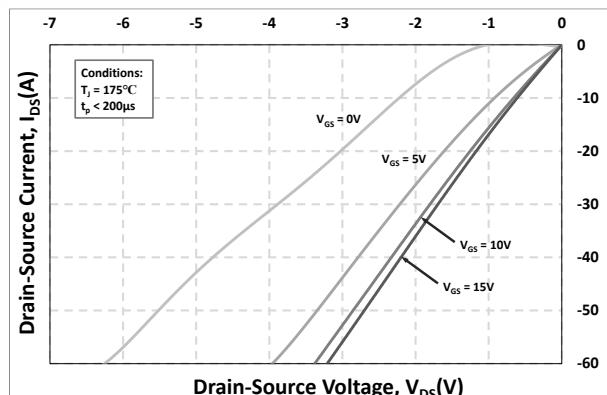


Figure 18. 3rd Quadrant Characteristic at 175°C



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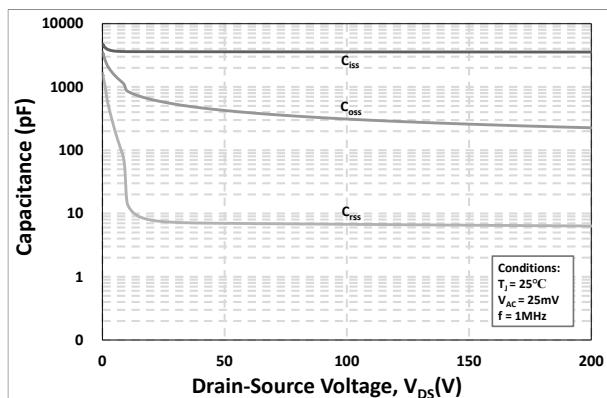


Figure 19. Capacitances vs. Drain-Source Voltage (0 - 200V)

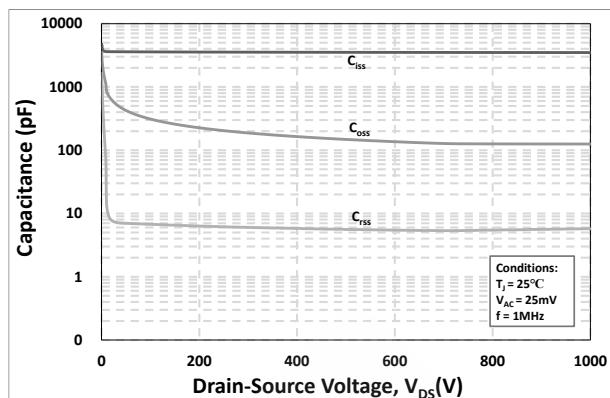


Figure 20. Capacitances vs. Drain-Source Voltage (0 - 1000V)

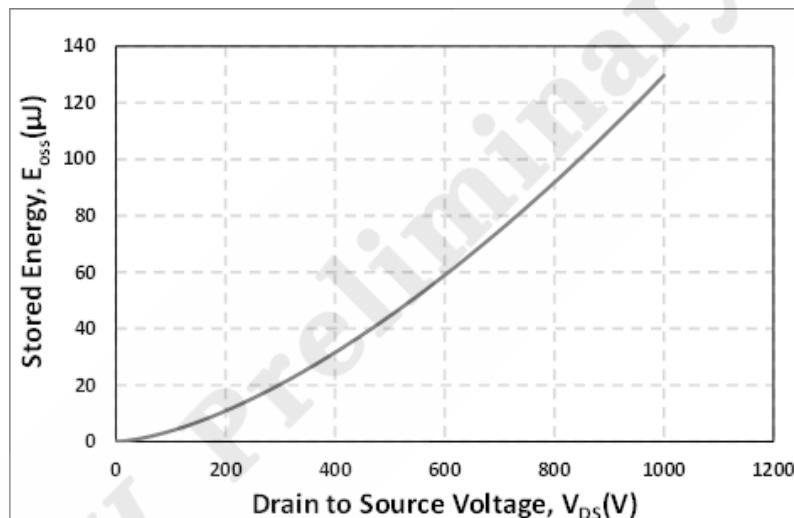
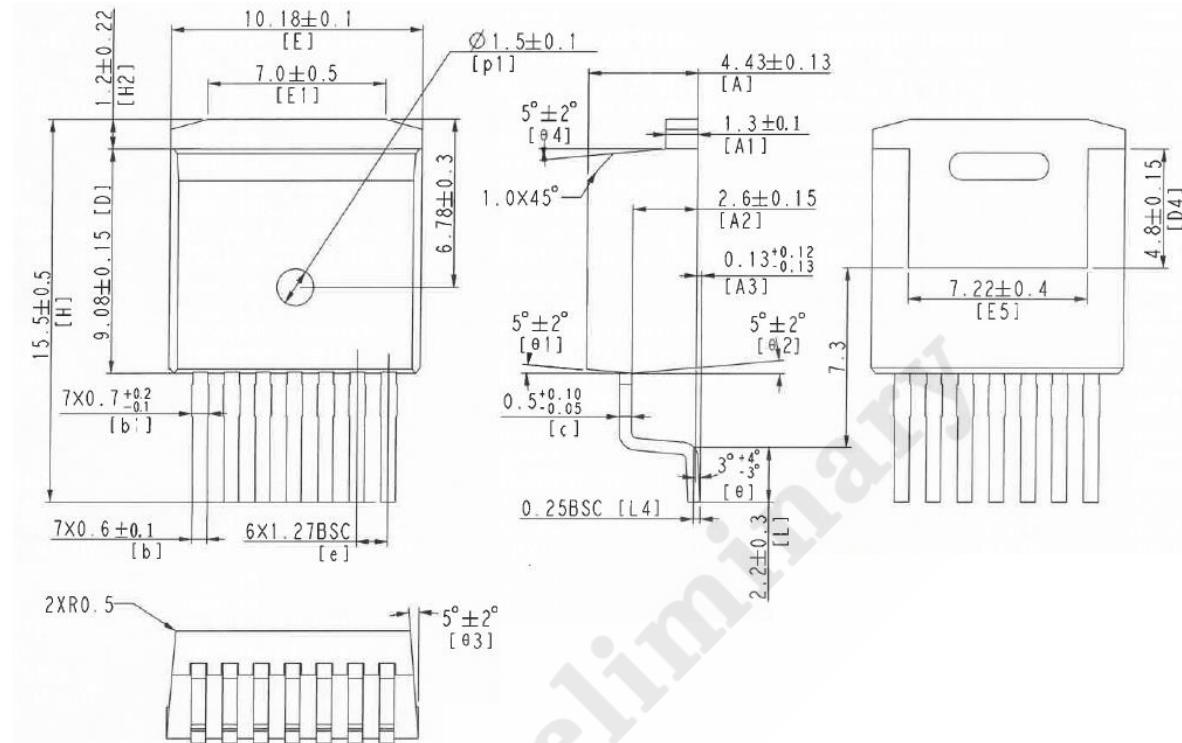


Figure 21. Output Capacitor Stored Energy



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6. Package Outlines



Drawing and Dimensions



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